# Isolating Failure-Inducing Combinations in Combinatorial Testing using Test Augmentation and Classification

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## Motivation

- Software normally has faults.
- Given a System Under Test (SUT) with N input parameters, a failure is usually caused by interaction among k parameters where k << N.</li>
- Problem:
  - Generating CT for even a small k (such as 5 or
     6) is computationally expensive for SUT with large N.
  - CT results may be insufficient for diagnosis due to failures caused by interactions among 5 or more parameters (aka *faulty combinations*)

#### Background

#### **Previous Approach**



#### **Our Approach**



## Problem

- 1. Often its hard to judge the size of faulty interactions.
- 2. Generating CT of higher strength is expensive.
- 3. Fault diagnosis on lower strength CT results may not be provide good results.

#### Agenda

- 1. Problem
- 2. Example
- 3. Approach
- 4. Proof of Concept
- 5. Conclusion

#### Example

- Consider TCAS v16
  - # of Parameters: 12
  - Total Input Space: 3 X 2<sup>3</sup> X 3 X 2 X 4 X 10<sup>2</sup> X 3 X 2 X 3 = 1036800
- Assume we don't know in advance the nature of failures.

# Example (contd..)

Parameters	Values
Cur_Vertical_Sep	299, 300, 601
High_Confidence	0, 1
Two_of_Three_Reports_Valid	0, 1
Own_Tracked_Alt	1, 2
Own_Tracked_Alt_Rate	
Other_Tracked_Alt	1, 2
Alt_Layer_Value	0,1,2,3
Up_Separation	0, 399, 400, 499, 500,
Down_Separation	0, 399, 400, 499, 500,
Other_RAC	0, 1, 2
Other_Capability	1, 2
Climb_Inherit	0,1

Example (continue..)

#### Characteristic of Failure (TCAS v16)

CT Strength	Failing/Total Number of Tests
2-way	0/156
3-way	1/461
4-way	6/1450
5-way	14/4309

# Example (continue..)

- Result of Classification Tree:
  - (EMPTY)
- Reason:
  - Data Set is Highly Unbalanced.
  - Not enough Failing Tests.

#### Approach



#### **Test Augmentation**

Use OFOT <sup>1</sup> (one factor one time) method to generate additional tests from failing tests. Ex: Given a Failing Test: 601,1,1,1,600,2,3,740,400,0,2,1 **OFOT** generates 300,1,1,1,600,2,3,740,400,0,2,1 299,1,1,1,600,2,3,740,400,0,2,1 601,0,1,1,600,2,3,740,400,0,2,1

1. C. Nie and H. Leung, "The minimal failure-causing schema of combinatorial testing," 2011.

## Test Augmentation (continue..)

Maximum number of tests generated by OFOT is

$$m \times \left(\sum_{i=1}^{k} a_i - k\right)$$

where m is total no of failing tests, k is the number of parameters, and a<sub>i</sub> is distinct input values for each parameter.

- This is far less than the number of tests required to build higher strength array.
- For Example: 6-way Tests: 6,785 vs OFOT: 612

#### Test Augmentation (continue..)

Run the classification tree algorithm

```
High_Confidence = 0: 0 (2248.0/12.0)
High Confidence = 1
  Alt Layer Value = 0
     Own Tracked Alt Rate = 600
       Cur Vertical Sep = 299: 0(149.0/12.0)
       Cur Vertical Sep = 300
          Two of Three Reports Valid = 0:0
(28.0/2.0)
          Two of Three Reports Valid = 1
             Other RAC = 0
                Other Tracked Alt = 1
                  Other_Capability = 1: 1 (4.0)
                  Other Capability = 2:0(3.0)
                Other_Tracked_Alt = 2:1(6.0)
...(and many more nodes)
```

#### Test Augmentation (continue..)

#### **Test Augmentation Result**

Version	Test Aug	Effectiveness
16	302/357	73%
26	407/407	80%

#### **Feature Selection**

- Can we do more?
  - Developers typically use classification tree to manually analyze the nature of faults
  - Clearly smaller the size of tree, easier will be the debugging process
- For Example:
  - Classification tree generated for TCAS has 56 nodes
  - Can we reduce the size of classification tree?

#### Feature Selection (continue..)

- Objective of Feature Selection
  - Identifying and removing irrelevant and redundant information as much as possible.
- What kind of feature Selection:
  - Correlation based feature selection (H.A.Mark, Ph.D.dissertation, Univ of Waikato, 1999.)

#### Feature Selection (contd..)

Parameters	Values
Cur_Vertical_Sep	299, 300, 601
High_Confidence	0, 1
Two_of_Three_Reports_Valid	<del>0, 1</del>
Own_Tracked_Alt	<del>1, 2</del>
Own_Tracked_Alt_Rate	
Other_Tracked_Alt	<del>1, 2</del>
Alt_Layer_Value	0,1,2,3
Up_Separation	0, 399, 400, 499, 500,
Down_Separation	0, 399, 400, 499, 500,
Other_RAC	0, 1, 2
Other_Capability	1, 2
Climb_Inherit	<del>0,1</del>

#### Feature Selection (Evaluation)

Version	Test Aug	Effectiven ess	Size of Tree	Feature Subset	Size of Reduced Tree	Effectiven ess
16	302/357	73%	56	8	31	65%
26	407/407	80%	85	10	28	74%

# Ranking

- For each leaf node that indicates a failure, a corresponding likely faulty combination is computed by
  - Taking the conjunction of the parameter values found in the path from the root node to the leaf node
  - Calculate its score



Combination: A =1 and B=1 10/12 = .83

### **Proof of Concept**

- Hypothesis: The faulty should show up higher in the rank.
- Final Outcome:
  - TCAS v26, our approach did found the faulty combination.
  - TCAS v16, out of two combinations, our approach found one of them.

#### **Proof of Concept**

#### **Real Fault**

```
int alt_sep_test() {
....
enabled=High_Confidence &&
    /*(Own_Tracked_Alt_Rate<=OLEV) && BUG */
    (Cur_Vertical_Sep>MAXALTDIFF);
....
}
```

HighConfidence=1 && OwnTrackedAltRate>OLEV(=600) && CurVerticalSep>MAXALTDIFF(=600)

## Conclusion

- Diagnosis of failure when the number of failures are low.
- Our approach:
  - Tries to balance the test generation and classification for fault diagnosis
- Proof of concept on two versions of TCAS

Thank you

#### **Questions?**